Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10821156	CHANG ET AL.
Examiner	Art Unit

2125

SEARCHED			
Class	Subclass	Date	Examiner
updated	***************************************	11/20/06	MNVB

Von Buhr, M.N.

	SEARCH NOT	res	
	Search Notes	Date	Examiner
updated		11/20/06	MNVB

INTERFERENCE SEARCH				
Class		Subclass	Date	Examiner
700	121, 112		11/20/06	MNVB

U.S. Patent and Trademark Office

Part of Paper No.: 20061120



Application No.	Applicant(s)
10/821,156	CHANG ET AL.
Examiner	Art Unit
Maria N. Von Buhr	2125

SEARCHED			
Class	Subclass	Date	Examiner
700	95,96,99- 102,112, 113,115- 121	3/20/2005	MNVB
438	14-18	3/20/2005	MNVB
	106-127		
1	905-909	1	1
updated		7/18/2005	MNVB
updated		11/29/2005	MNVB
и		8/16/2006	HNVB
60		8/16/2006	nnes
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
700	121,112	11/20/06	nuis
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PALM inventor search to check for double patenting	3/20/2005	MNVB	
PLUS search - see enclosed notes	3/20/2005	MNVB	
EAST (USPAT, USPGPubs, JPO, EPO, Derwent & IBMTDB files) - see enclosed notes	3/20/2005	MNVB	
updated	7/8/2005	MNVB	
updated	11/29/2005	MNVB	
updated	8/16/06	mars mais	

